


Search Notes 	Application/Control No. 10626596	Applicant(s)/Patent Under Reexamination SHEN ET AL.
	Examiner GERMAN VIANA DI PRISCO	Art Unit 2617

SEARCHED			
Class	Subclass	Date	Examiner
370	352	4/17/2008	GV

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	4/17/2008	GV
Inventor name and Assignee search in PALM ExPO and EAST	4/17/2008	GV
Consulted with Rafael Perez-Gutierrez	4/17/2008	GV
EPO Database(http://ep.espacenet.com)	4/17/2008	GV
Updated search	12/10/2008	GV

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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